

**Search Notes**

Application/Control No.

10/608,184

Examiner

Elias B. Hiruy

Applicant(s)/Patent under  
Reexamination

KIM, HYOUNG-IL

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
			1

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched East: US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	10/3/2005	EH
Searched IEEE using key words	9/21/2005	EH
(Several Plural many numerous) near3 control\$4) and accuracy and overshoot and delay and response and settling and time	10/3/2005	EH
motor and (driv\$4 near3 (environment\$1 condition)) and ((several plural many numerous) near3 control\$4) and (control\$3 near	10/3/2005	EH
Requested a fast and focused search from STI	10/3/2005	EH